

**Search Notes**

Application/Control No.

10/635,067

Examiner

Khai M. Nguyen

Applicant(s)/Patent under  
Reexamination

LIANG ET AL.

Art Unit

2617

**SEARCHED**

Class	Subclass	Date	Examiner
455	277.2 277.1 435.3 435.2 41.2	11/6/2007	KN
455	41.2 63.1	11/6/2007	KN
455	63.3 67.13	11/6/2007	KN
455	114.2	11/6/2007	KN
455	101	11/6/2007	KN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
see	attached	11/6/2007	KN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (see attached)	11/6/2007	KN